

<b>Notice of References Cited</b>	Application/Control No. 10/533,464		Applicant(s)/Patent Under Reexamination MAYERESSE ET AL.	
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*	B	US-2006/0127415	06-2006	Mayeresse, Yves	424/234.1
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	N	WO 02/00249 A2	01-2002	WO	Boutriau et al.	
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#### NON-PATENT DOCUMENTS

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